

SERIAL NO.

**FILING DATE**  
**April 23, 2004**

**GROUP**

(PTO-1449)

## U.S. PATENT DOCUMENTS

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**FOREIGN PATENT DOCUMENTS**

FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number & -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
AS	A	P2002-98951	04/05/2002	SONY CORP		Japanese (w/ English Abstract)	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
57810-101SERIAL NO.  
10/830,088APPLICANT  
Nobuhiko ODA, et al.FILING DATE  
April 23, 2004GROUP  
2821

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
AS		US 2002/0118327 A1	08/29/2002	Yamada et al.	
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EXAMINER

Andrew Schleicher

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9/14/06

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